IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

FEB 20 200

In re Application of

Arthur ZWINGENBERGER et al.

Serial No.:

10/576,238

Art Unit:

2165

Filed: December 29, 2006

Examiner:

not yet assigned

SYSTEM FOR MANAGEMENT OF PROCESSED INSTRUMENTS

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.97(e), the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached form PTO-1449. It is respectfully requested that the references be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

Applicants respectfully submit that each item contained in the accompanying Information Disclosure Statement was first cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the Information Disclosure Statement, therefore, no fee is required.

Respectfully submitted,

CLARK & BRODY

Conrad J. Clark

Registration No. 30,340

Customer No. 22902

1090 Vermont Avenue, NW, Suite 250

Washington DC 20005 Telephone: 202-835-1111

Facsimile: 202-835-1755

Docket No.: 70566-0021US Date: February 20, 2007

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.

SERIAL NO.

70566-0021US

10/576,238

APPLICANT

Arthur Zwingenberger et al.

FILING DATE

GROUP ART UNIT

12/29/2006

2165

LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	٠	DOCUMENT NO.	DATE	NAME ·	CLASS	SUB- CLASS	FILING DATE
	1.	2002/0161460 A1	10/31/2002	Noguchi			
				*			7
	·						
						31	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRA YES	NSLA NO	TION PART.
	2.	WO 00/45331	08/03/2000	PCT			х		
	3.	WO 00/58752	10/05/2000	PCT			х		
					-				
•									

	4.	S. d'Hont, "The Cutting Edge of RFID Technology and Applications for Manufacturing and Distribution", Internet Article, Research Paper, Texas Instruments, 2001, pgs. 1-13, XP002408100, URL:http://www.ti.com/rfid/docs/manuals/whtPapers/manuf_dist.pdf				
EXAMINE	R	DATE CONSIDERED				
*EXAMINI		nitial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through				

citation if not in conformance and not considered. Include copy of this form with next communication to applicant.